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SINGLE DIGIT LED DISPLAY (4.0 Inch)



Lead-Free Parts

## LSD4015/6WK-XX-PF

# DATA SHEET

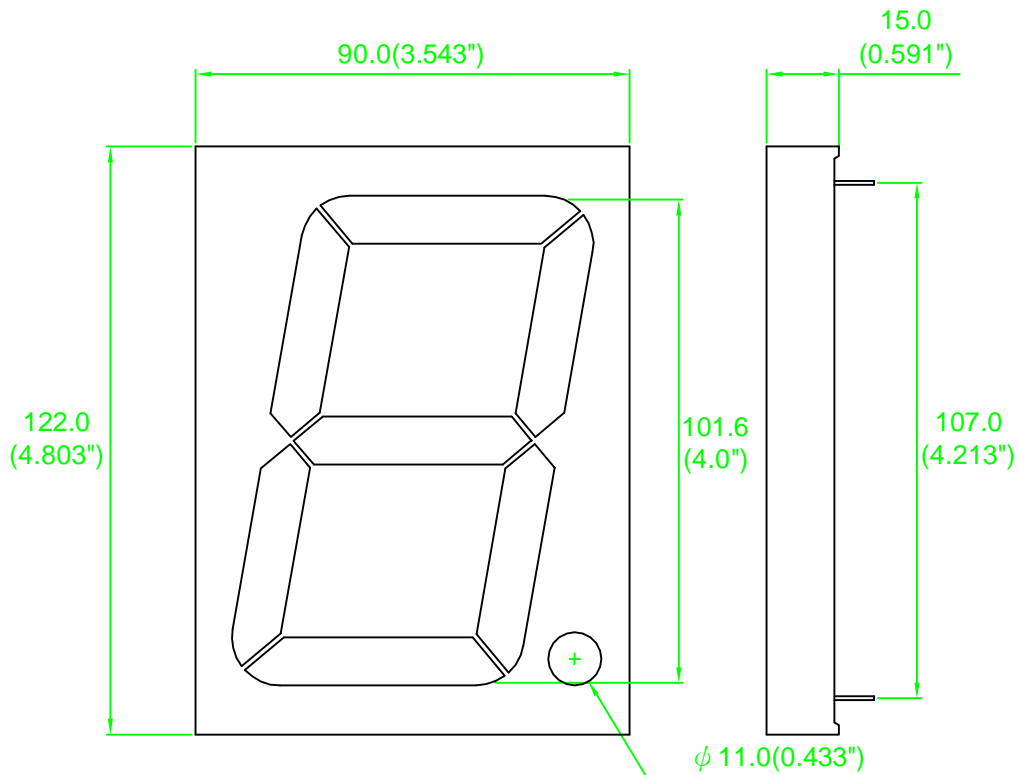
DOC. NO : QW0905-LSD4015/6WK-XX-PF

REV. : A

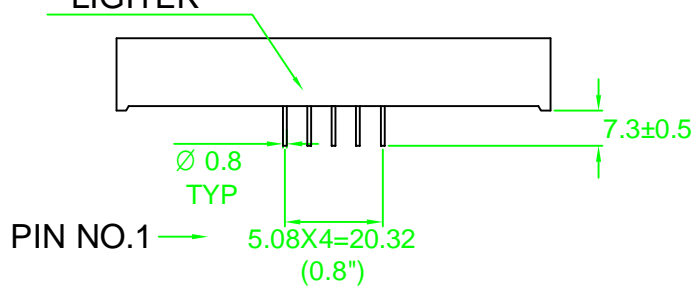
DATE : 7 -Aug. - 2008



### Package Dimensions



LSD4015/6WK-XX-PF  
LIGITEK

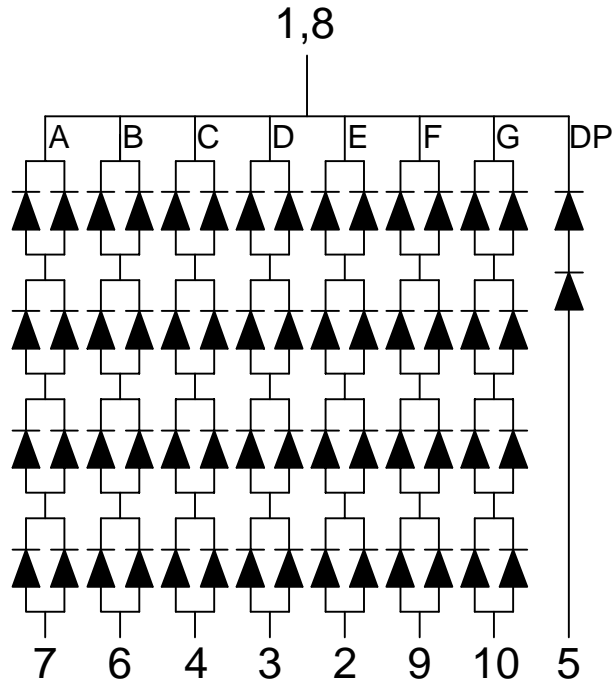


Note : 1.All dimension are in millimeters and (Inch) tolerance is  $\pm 0.25(0.01)$ " unless otherwise noted.  
2.Specifications are subject to change without notice.

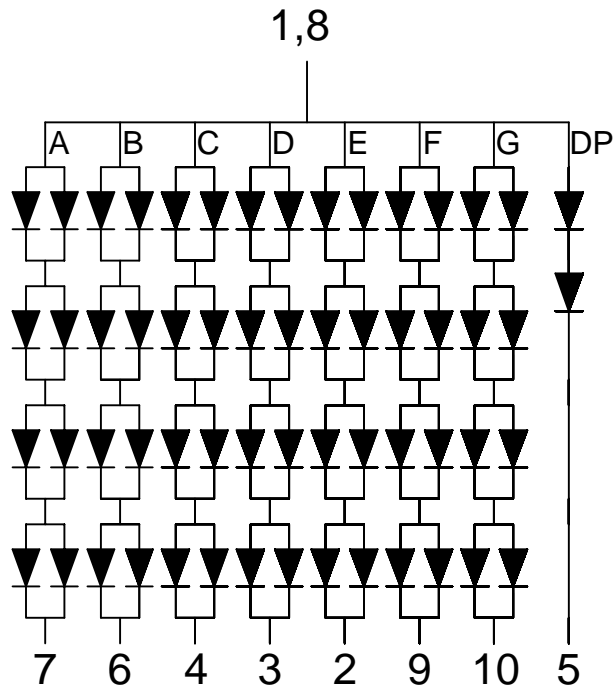


Internal Circuit Diagram

LSD4015WK-XX-PF



LSD4016WK-XX-PF





### Electrical Connection

PIN NO.	LSD4015WK-XX-PF	PIN NO.	LSD4016WK-XX-PF
1	Common Cathode	1	Common Anode
2	Anode E	2	Cathode E
3	Anode D	3	Cathode D
4	Anode C	4	Cathode C
5	Anode DP	5	Cathode DP
6	Anode B	6	Cathode B
7	Anode A	7	Cathode A
8	Common Cathode	8	Common Anode
9	Anode F	9	Cathode F
10	Anode G	10	Cathode G

**Absolute Maximum Ratings at Ta=25 °C**

Parameter	Symbol	Ratings	UNIT
		WK	
Forward Current	IF	20	mA
Peak Forward Current Duty 1/10@10KHz	IFP	100	mA
Power Dissipation	PD	120	mW
Reverse Current @5V	Ir	50	$\mu A$
Electrostatic Discharge( * )	ESD	150	V
Operating Temperature	Topr	-20~ +80	°C
Storage Temperature	Tstg	-30~ +100	°C

\* Static Electricity or power surge will damage the LED. Use of a conductive wrist band or anti-electrosatic glove is recommended when handing these LED. All devices, equipment and machinery must be properly grounded.

**Part Selection And Application Information(Ratings at 25°C)**

PART NO	LED Color	common cathode or anode	Chromaticity Coordinates (Typ.)		Electrical				IV-M
					Vf(v)		Iv(ucd)		
					Typ.	Max.	Min.	Typ.	
LSD4015WK-XX-PF	White	Common Cathode	X	Y	7.0	8.0	43000	50000	2:1
LSD4016WK-XX-PF		Common Anode	0.28	0.28					

Note : 1.The forward voltage data did not including  $\pm 0.1V$  testing tolerance.

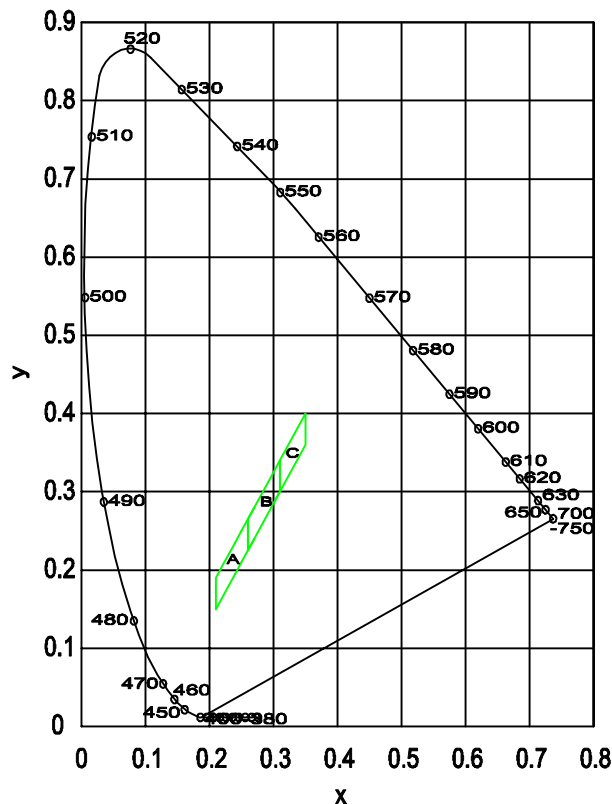
2. The luminous intensity data did not including  $\pm 15\%$  testing tolerance.



. Chromaticity Coordinates Specifications for Bin Grading

BIN	X	Y	BIN	X	Y	BIN	X	Y
A1	0.21	0.190	B1	0.26	0.265	C1	0.31	0.340
	0.21	0.150		0.26	0.225		0.31	0.300
	0.22	0.165		0.27	0.240		0.32	0.315
	0.22	0.205		0.27	0.280		0.32	0.355
A2	0.22	0.205	B2	0.27	0.280	C2	0.32	0.355
	0.22	0.165		0.27	0.240		0.32	0.315
	0.23	0.180		0.28	0.255		0.33	0.330
	0.23	0.220		0.28	0.295		0.33	0.370
A3	0.23	0.220	B3	0.28	0.295	C3	0.33	0.370
	0.23	0.180		0.28	0.255		0.33	0.330
	0.24	0.195		0.29	0.270		0.34	0.345
	0.24	0.235		0.29	0.310		0.34	0.385
A4	0.24	0.235	B4	0.29	0.310	C4	0.34	0.385
	0.24	0.195		0.29	0.270		0.34	0.345
	0.25	0.210		0.30	0.285		0.35	0.360
	0.25	0.250		0.30	0.325		0.35	0.400
A5	0.25	0.250	B5	0.30	0.325			
	0.25	0.210		0.30	0.285			
	0.26	0.225		0.31	0.300			
	0.26	0.265		0.31	0.340			

. CIE Chromaticity Diagram



**Test Condition For Each Parameter**

Parameter	Symbol	Unit	Test Condition
Forward Voltage Per Byte	V <sub>f</sub>	volt	I <sub>f</sub> =20mA
Luminous Intensity Per Byte	I <sub>v</sub>	ucd	I <sub>f</sub> =10mA
Dominant Wavelength	$\lambda_D$	nm	I <sub>f</sub> =20mA
Spectral Line Half-Width	$\Delta \lambda$	nm	I <sub>f</sub> =20mA
Reverse Current Any Byte	I <sub>r</sub>	$\mu A$	V <sub>r</sub> =5V
Luminous Intensity Matching Ratio	IV-M		



# Typical Electro-Optical Characteristics Curve

WK LED

Fig.1 Forward current vs. Forward Voltage

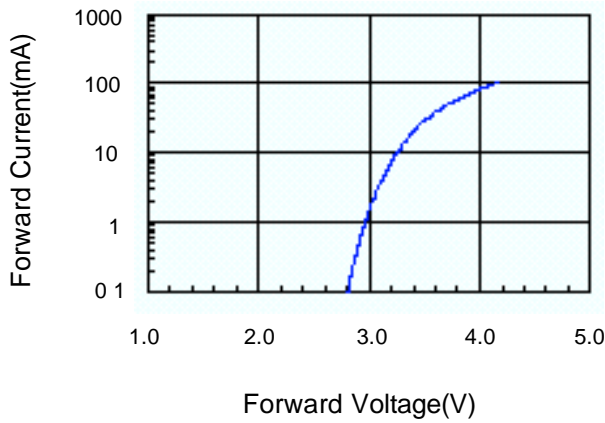


Fig.2 Relative Intensity vs. Forward Current

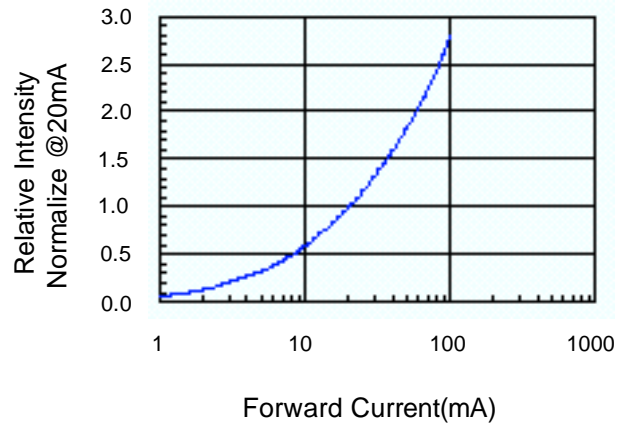


Fig.3 Forward Voltage vs. Temperature

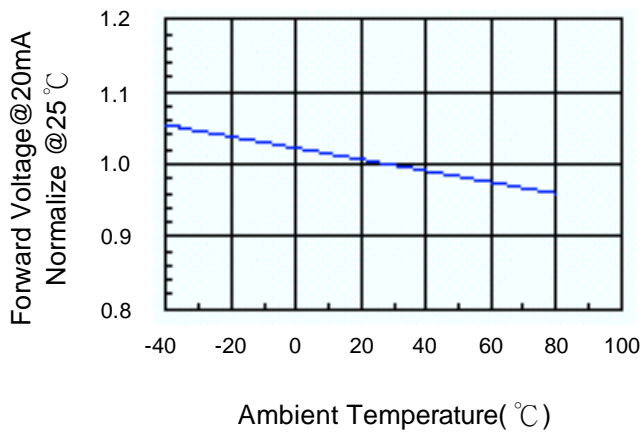


Fig.4 Relative Intensity vs. Temperature

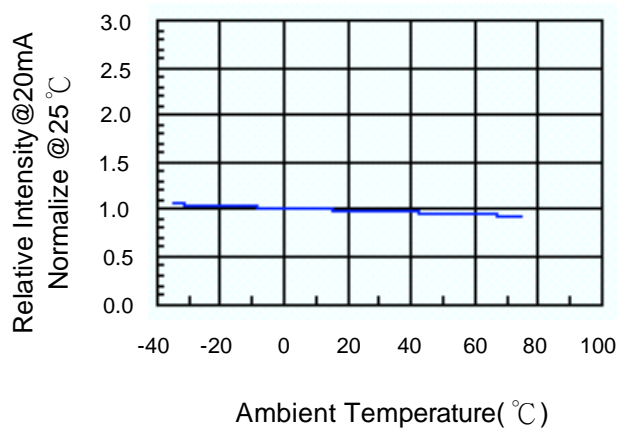
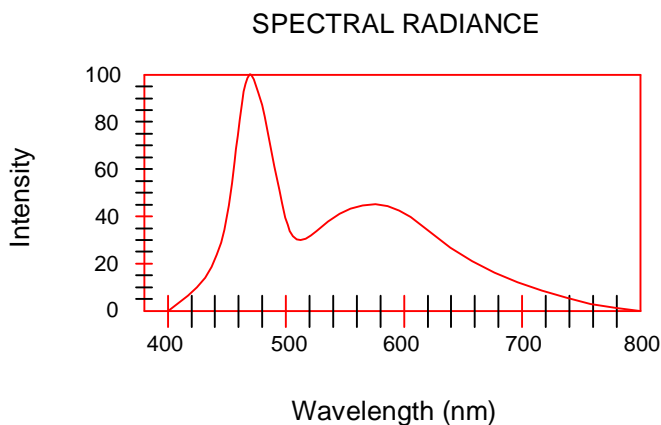


Fig.5 Luminous Spectrum (Ta=25 °C)







### Soldering Condition(Pb-Free)

#### 1.Iron:

Soldering Iron:30W Max

Temperature 350° C Max

Soldering Time:3 Seconds Max(One time only)

Distance:Solder Temperature 1/16 Inch Below Seating  
Plane For 3 Seconds At 260° C

#### 2.Wave Soldering Profile

Dip Soldering

Preheat: 120° C Max

Preheat time: 60seconds Max

Ramp-up

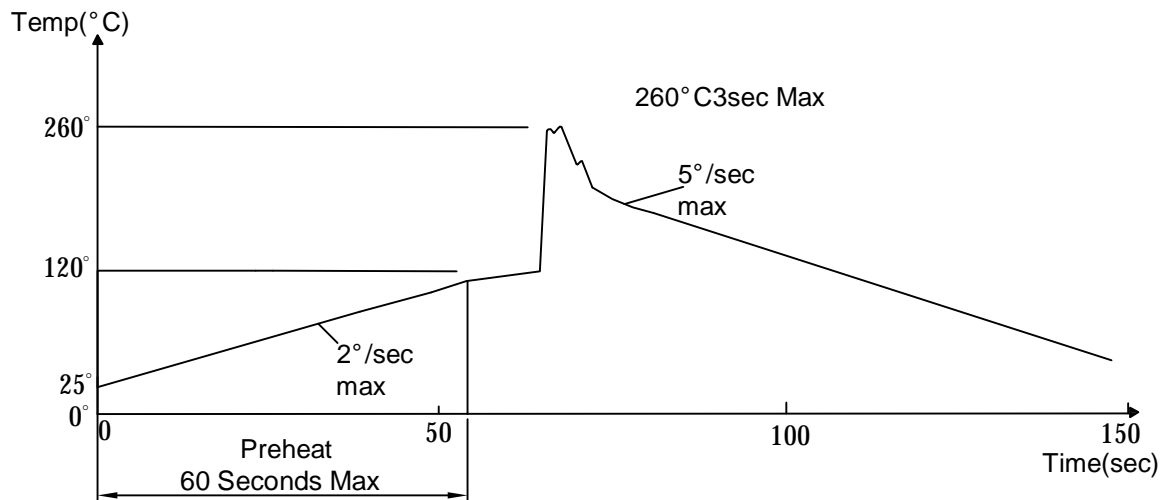
2° C/sec(max)

Ramp-Down:-5° C/sec(max)

Solder Bath:260° C Max

Dipping Time:3 seconds Max

Distance:Solder Temperature 1/16 Inch Below Seating  
Plane For 3 Seconds At 260° C



Note: 1.Wave solder should not be made more than one time.

2.You can just only select one of the soldering conditions as above.



Reliability Test:

Test Item	Test Condition	Description	Reference Standard
Operating Life Test	1.Under Room Temperature 2.If=10mA 3.t=1000 hrs (-24hrs, +72hrs)	This test is conducted for the purpose of determining the resistance of a part in electrical and thermal stressed.	MIL-STD-750: 1026 MIL-STD-883: 1005 JIS C 7021: B-1
High Temperature Storage Test	1.Ta=105°C±5°C 2.t=1000 hrs (-24hrs, +72hrs)	The purpose of this is the resistance of the device which is laid under condition of high temperature for hours.	MIL-STD-883:1008 JIS C 7021: B-10
Low Temperature Storage Test	1.Ta=-40°C±5°C 2.t=1000 hrs (-24hrs, +72hrs)	The purpose of this is the resistance of the device which is laid under condition of low temperature for hours.	JIS C 7021: B-12
High Temperature High Humidity Test	1.Ta=65°C±5°C 2.RH=90%~95% 3.t=240hrs±2hrs	The purpose of this test is the resistance of the device under tropical for hours.	MIL-STD-202:103B JIS C 7021: B-11
Thermal Shock Test	1.Ta=105°C±5°C & -40°C±5°C (10min) (10min) 2.total 10 cycles	The purpose of this is the resistance of the device to sudden extreme changes in high and low temperature.	MIL-STD-202: 107D MIL-STD-750: 1051 MIL-STD-883: 1011
Solder Resistance Test	1.T.Sol=260°C±5°C 2.Dwell time= 10±1sec.	This test intended to determine the thermal characteristic resistance of the device to sudden exposures at extreme changes in temperature when soldering the lead wire.	MIL-STD-202: 210A MIL-STD-750: 2031 JIS C 7021: A-1
Solderability Test	1.T.Sol=230°C±5°C 2.Dwell time=5±1sec	This test intended to see soldering well performed or not.	MIL-STD-202: 208D MIL-STD-750: 2026 MIL-STD-883: 2003 JIS C 7021: A-2